

Notice of References Cited

Application/Control No.

09/419,901

Applicant(s)/Patent Under
Reexamination
VAN EYK ET AL.

Examiner

Lisa V. Cook

Art Unit

1641

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U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-			
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 96/10078	04-1996	PCT/IB95/00808	Takahashi et al.	C12N 5/20
	O	WO 94/27156	11-1994	PCT/US94/05468	Wicks et al.	G01N 33/68
	P					
	Q					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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